TOSHIBA Insulated Gate Bipolar Transistor Silicon N Channel IGBT

GT60N322

Voltage Resonance Inverter Switching Application

Unit: mm

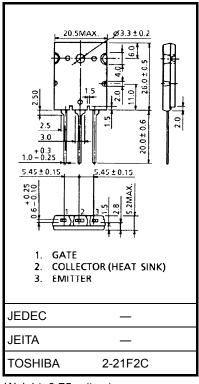
• Enhancement mode type

• High speed : t_f = 0.11 μs (typ.) (I_C = 60 A) • Low saturation voltage : V_{CE} (sat) = 2.4 V (typ.) (I_C = 60 A)

- FRD included between emitter and collector
- TO-3P(LH) (Toshiba package name)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Collector-emitter voltage		V_{CES}	1000	V	
Gate-emitter voltage		V_{GES}	±25	V	
Continuous collector current	@ Tc = 100°C	Ic	29	Α	
	@ Tc = 25°C	iC	57		
Pulsed collector current		I _{CP}	120	А	
Diode forward current	DC	lF	15	Α	
	Pulsed	I _{FP}	120		
Collector power dissipation	@ Tc = 100°C	Pc	80	W	
	@ Tc = 25°C	FC	200		
Junction temperature		Tj	150	°C	
Storage temperature range		T _{stg}	-55 to 150	°C	



Weight: 9.75 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

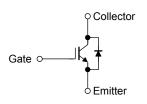
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

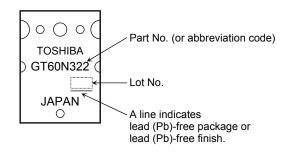
Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance (IGBT)	R _{th (j-c)}	0.625	°C/W
Thermal resistance (diode)	R _{th (j-c)}	4.0	°C/W

Equivalent Circuit

Marking

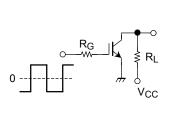


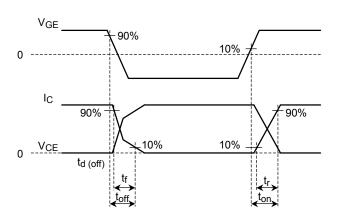


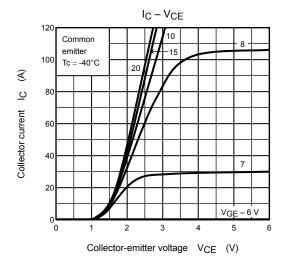
Electrical Characteristics (Ta = 25°C)

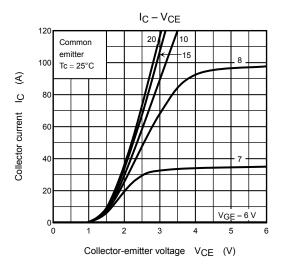
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GES}	$V_{GE} = \pm 25 \text{ V}, V_{CE} = 0$	_	_	±500	nA
Collector cut-off current		I _{CES}	V _{CE} = 1000 V, V _{GE} = 0	_	_	0.1	mA
Gate-emitter cut-	off voltage	V _{GE} (OFF)	I _C = 60 mA, V _{CE} = 5 V	4.0	_	7.0	V
Collector-emitter	saturation voltage	V _{CE} (sat)	I _C = 60 A, V _{GE} = 15 V	_	2.4	2.9	V
Input capacitance		C _{ies}	V _{CE} = 10 V, V _{GE} = 0, f = 1 MHz	_	4200	-	pF
Switching time	Rise time	t _r	Resistive Load	_	0.33	_	- µs
	Turn-on time	t _{on}	V _{CC} = 600 V, I _C = 60 A	_	0.45	-	
	Fall time	t _f	V_{GG} = ±15 V, R_{G} = 51 Ω	_	0.11	0.22	
	Turn-off time	t _{off}	(Note 1)	_	0.41	_	
Diode forward voltage V _F		I _F = 15 A, V _{GE} = 0	_	1.2	1.9	V	
Reverse recovery time t _{rr}		t _{rr}	I _F = 60 A, di/dt = -20 A/μs	_	0.75	1.7	μs

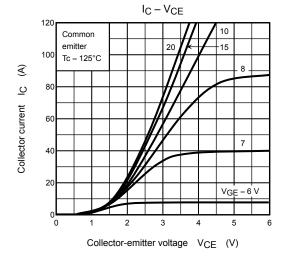
Note 1: Switching time measurement circuit and input/output waveforms

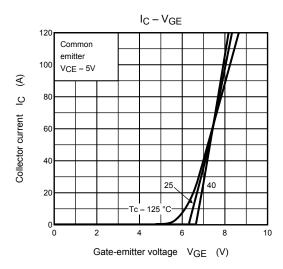


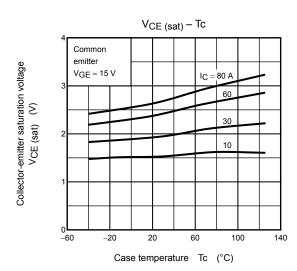


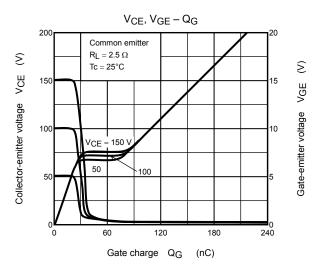


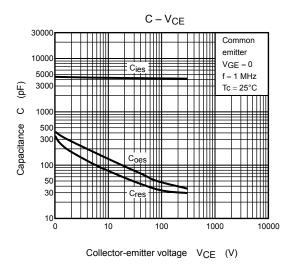


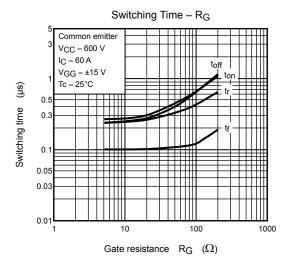


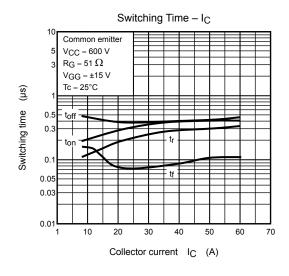


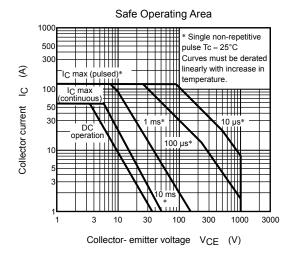


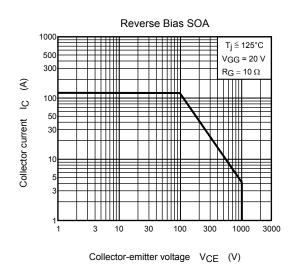




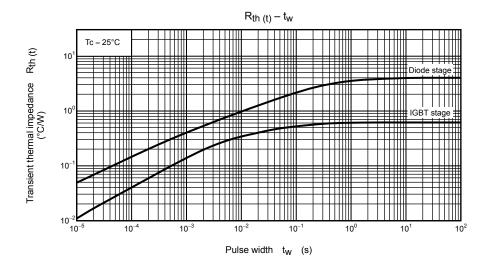


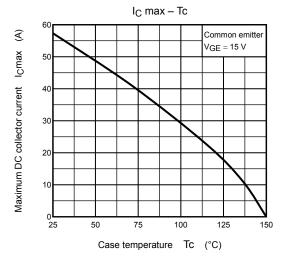


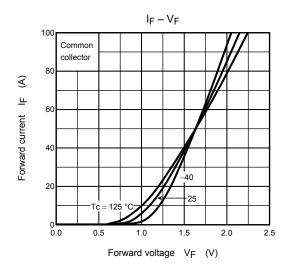


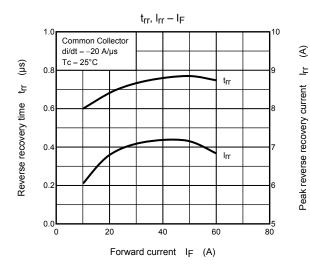


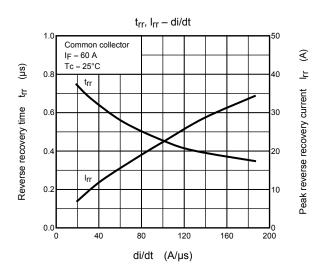
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